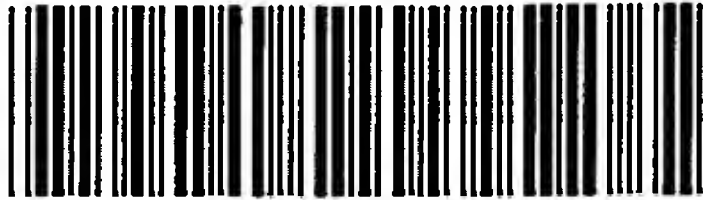


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,103	DONALDSON ET AL.	
	Examiner	Art Unit	
	Phallaka Kik	2825	

SEARCHED			
Class	Subclass	Date	Examiner
716	20,21,16,2	10/24/2005	PK
29	847	10/24/2005	PK
174	255	10/24/2005	PK
361	794,805	10/24/2005	PK
Above	updated	1/31/2006	PK
716	15	1/31/2006	PK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
716	15,16,20	1/31/2006	PK
716	2	1/31/2006	PK
174	255	1/31/2006	PK
--USPGPUB (see attached)		1/31/2006	PK

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
BRS (EAST) --USPAT, USPGPUB Cls/sub searched: 716/1-21; 29/847,846,852,831; 174/250,255,261,262; 257/e23.175 (see attached)	10/24/2005	PK
--USPAT, USPGPUB (con't) Cls/Sub searched: 361/794,795,805,778; 439/44,48 (see attached)	10/24/2005	PK
Above updated search (see attached)	1/31/2006	PK
Consulted with Examiner John Vigushin --Suggested crossed-reference to 174/255	1/31/2006	PK
Consulted with Examiner Patel Ishwar --suggested search in 174/255, 260, 261, 262; x-ref. to these cls/sub not necessary	1/31/2006	PK
--EPO, JPO, IBM TDB, Derwent (see attached)	10/24/2005	PK
IEE/IEEE Xplore (see attached)	10/24/2005	PK